

<b>Notice of References Cited</b>		Application/Control No. 10/664,040	Applicant(s)/Patent Under Reexamination THIGPEN, F. BRUCE	
		Examiner Corey P. Chau	Art Unit 2615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,584,202 B1	06-2003	Montag et al.	381/63
*	B	US-4,819,269	04-1989	Klayman, Arnold I.	381/307
*	C	US-6,104,825 A	08-2000	Thigpen, F. Bruce	381/408
*	D	US-2003/0021433 A1	01-2003	Lee, Kyung Lak	381/302
*	E	US-5,966,453 A	10-1999	Koyano et al.	381/86
*	F	US-6,389,147 B1	05-2002	Rush et al.	381/389
*	G	US-2002/0081980 A1	06-2002	Reus, Richard J.	455/90
*	H	US-2002/0076061 A1	06-2002	Ashtiani et al.	381/86
*	I	US-4,612,530	09-1986	Kurth et al.	340/429
*	J	US-2003/0108211 A1	06-2003	Dreyer et al.	381/86
*	K	US-2004/0047476 A1	03-2004	Sato, Shinichi	381/089
*	L	US-5,031,220	07-1991	Takagi et al.	381/86
*	M	US-2006/0034467 A1	02-2006	Sleboda et al.	381/086

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.